Application/Control No. Applicant(s)/Patent Under Reexamination 10/609,503 SHIMIZU ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 2879 Joseph L. Williams **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-	-		
	В	US-			
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	_	US-			
	٦	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002270020 A	09-2002	Japan	TAKEDA et al.	F21V 08/00
	0					
	Р					
	Q					
	R				,	
	s					
	Т					

NON-PATENT DOCUMENTS

NON-FATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	×							

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.